

FCC

EMC

TEST REPORT

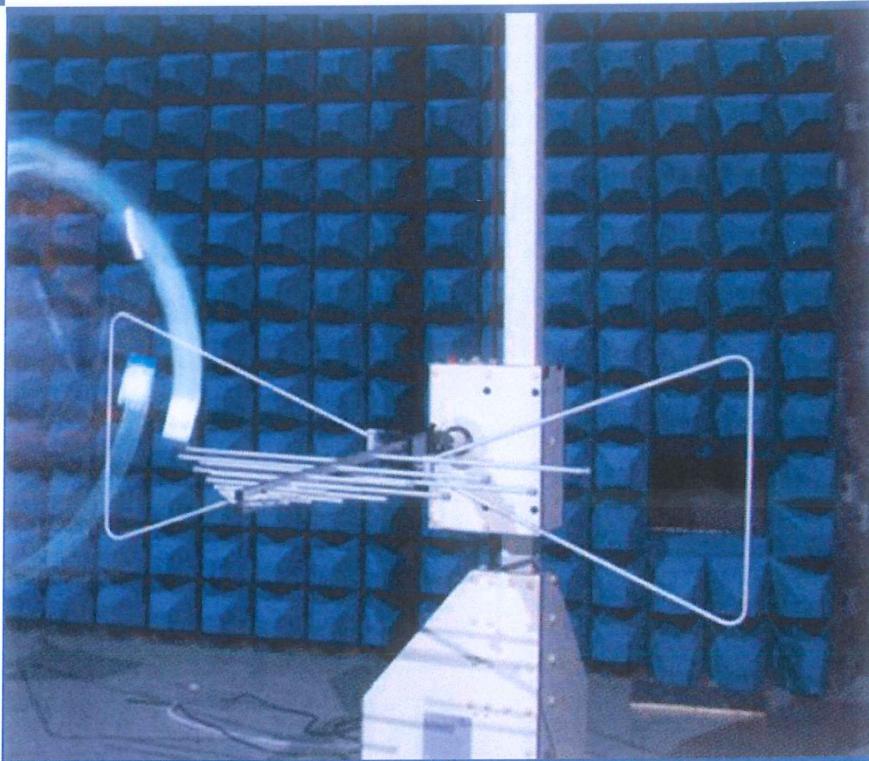
ISSUED BY  
Shenzhen BALUN Technology Co., Ltd.



FOR  
X1 FDD-LTE Smartphone

ISSUED TO  
TP-LINK Technologies Co., Ltd.

Building 24-1F/3F/4F/5F, 28-1F/2F/3F/4F Science and Technology Park, Shennan Road, Nanshan District, Shenzhen City, Guangdong Province, P. R. China



Tested by: Xia Long  
Date: May 15, 2017  
Approved by: Liao Jianming  
Date: May 15, 2017



Report No.: BL-SZ1720179-402  
EUT Name: X1 FDD-LTE Smartphone  
Model Name: TP902C  
Brand Name: neffos  
Test Standard: 47 CFR Part 15 Subpart B  
FCC ID: TE7X1V1  
Test Conclusion: Pass  
Test Date: Apr. 10, 2017 ~ May 14, 2017  
Date of Issue: May 15, 2017

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## Revision History

Version	Issue Date	Revisions Content
<u>Rev. 01</u>	<u>Apr. 21, 2017</u>	<u>Initial Issue</u>
<u>Rev. 02</u>	<u>May 15, 2017</u>	<u>Increases the relevance description with the report BL-SZ1720179-401, retest the USB mode and update the data</u>

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## 1 GENERAL INFORMATION

### 1.1 Identification of the Testing Laboratory

Company Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

### 1.2 Identification of the Responsible Testing Location

Test Location	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Accreditation Certificate	The laboratory has been listed by Industry Canada to perform electromagnetic emission measurements. The recognition numbers of test site are 11524A-1. The laboratory has been listed by US Federal Communications Commission to perform electromagnetic emission measurements. The recognition numbers of test site are 832625. The laboratory is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L6791.
Description	All measurement facilities used to collect the measurement data are located at Block B, FL 1, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China 518055

### 1.3 Laboratory Condition

Ambient Temperature	20°C~25°C
Ambient Relative Humidity	45% - 55%
Ambient Pressure	100 kPa - 102 kPa

### 1.4 Announce

- (1) The test report reference to the report template version v6.4.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
- (5) This document may not be altered or revised in any way unless done so by BALUN and all revisions are duly noted in the revisions section.
- (6) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

## 2 PRODUCT INFORMATION

### 2.1 Applicant Information

Applicant	TP-LINK Technologies Co., Ltd.
Address	Building 24-1F/3F/4F/5F, 28-1F/2F/3F/4F Science and Technology Park, Shennan Road, Nanshan District, Shenzhen City, Guangdong Province, P. R. China

### 2.2 Manufacturer Information

Manufacturer	TP-LINK Technologies Co., Ltd.
Address	Building 24-1F/3F/4F/5F, 28-1F/2F/3F/4F Science and Technology Park, Shennan Road, Nanshan District, Shenzhen City, Guangdong Province, P. R. China

### 2.3 Factory Information

Factory	N/A
Address	N/A

### 2.4 General Description for Equipment under Test (EUT)

EUT Name	X1 FDD-LTE Smartphone
Model Name Under Test	TP902C
Series Model Name	TP902C , TP902CXYZ
Description of Model name differentiation	X=2 or 4 ( 2 indicates Cloudy Grey, 4 indicates Sunrise Gold); Y=4 or 6 ( 4 indicates the memory is 2G RAM + 16G Flash, 6 indicates the memory is 3G RAM + 32G Flash ); ZZ indicates different national.
Hardware Version	N/A
Software Version	N/A
Dimensions (Approx.)	N/A
Weight (Approx.)	N/A
Random-access Memory	2G RAM + 16G Flash
Network and Wireless connectivity	2G Network GSM/GPRS/EDGE 850/1900 MHz 3G Network WCDMA/HSDPA/HSUPA Band 2/4/5 4G Network FDD LTE Band 2/4/7 Bluetooth, WIFI, FM, GPS, GLONASS

## 2.5 Ancillary Equipment

Ancillary Equipment 1	Battery	
	Brand Name	neffos
	Model No.	NBL-38A2250
	Serial No.	N/A
	Capacitance	2020 mAh
	Rated Voltage	3.85 V
	Limit Charge Voltage	4.4 V
Ancillary Equipment 2	Charger	
	Brand Name	neffos
	Model Name	N050100-2B3
	Rated Input	100-240 V ~, 50/60 Hz, 300 mA
Ancillary Equipment 3	Earphone	
	Length(Approx.)	95 cm
Ancillary Equipment 4	USB Cable	
	Length(Approx.)	100 cm

## 2.6 Technical Information

The requirement for the following technical information of the EUT was tested in this report:

The Highest Speed of Processor	1.3 GHz
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## 3 SUMMARY OF TEST RESULTS

### 3.1 Test Standards

No.	Identity	Document Title
1	FCC 47 CFR Part 15 Subpart B (10-1-15 Edition)	Unintentional Radiators
2	ANSI C63.4-2014	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz

### 3.2 Verdict

No.	Description	FCC Rule	Test Verdict	Result
1	Radiated Emission	15.109	Pass	Annex A.1
2	Conducted Emission, AC Ports	15.107	Pass	Annex A.2

Note: Because of the EUT and the test sample (which in the test report No. is BL-SZ1720179-401, and it issued by Shenzhen BALUN Technology Co., Ltd. On May 15, 2017) just have the different memory version. The other hardware circuit all the same. So all of the test items please refer to the report BL-SZ1720179-401 (issued by Shenzhen BALUN Technology Co., Ltd. On May 15, 2017 and only evaluated Radiated Emission below 1GHz).

### 3.3 Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Measurement	Value
Conducted emissions (9 kHz-30 MHz)	3.23 dB
Radiated emissions (30 MHz-1 GHz)	4.30 dB
Radiated emissions (1 GHz-18 GHz)	4.81 dB
Radiated emissions (18 GHz-40 GHz)	5.71 dB

## 4 GENERAL TEST CONFIGURATIONS

### 4.1 Test Environments

Environment Parameter	Selected Values During Tests			
	Temperature	Voltage	Relative Humidity	Ambient Pressure
Normal Temperature, Normal Voltage (NTNV)	23°C~26°C	AC 120 V/60 Hz	50%-55%	100 to 102 kPa

### 4.2 Test Equipment List

Radiated Emission Test For Frequency Below 1 GHz						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	ROHDE&SCHWABE RZ	ESRP	101036	2016.07.05	2017.07.04	<input checked="" type="checkbox"/>
Test Antenna-Bi-Log	SCHWARZBECK	VULB 9163	9163-977	2016.07.19	2018.07.18	<input checked="" type="checkbox"/>
Test Antenna-Horn	SCHWARZBECK	BBHA 9120D	9120D-1600	2016.07.12	2018.07.11	<input type="checkbox"/>
Anechoic Chamber	EMC Electronic Co., Ltd	20.10*11.60 *7.35m	N/A	2016.08.09	2018.08.08	<input checked="" type="checkbox"/>

Radiated Emission Test For Frequency Above 1 GHz						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	KEYSIGHT	N9038A	MY53220118	2016.09.09	2017.09.08	<input checked="" type="checkbox"/>
Test Antenna-Bi-Log	SCHWARZBECK	VULB 9163	9163-624	2015.07.22	2017.07.21	<input type="checkbox"/>
Test Antenna-Horn	SCHWARZBECK	BBHA 9120D	9120D-1148	2015.07.22	2017.07.21	<input checked="" type="checkbox"/>
Anechoic Chamber	RAINFORD	9m*6m*6m	N/A	2017.02.21	2019.02.20	<input checked="" type="checkbox"/>

Conducted Emission Test						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	ROHDE&SCHWABE RZ	ESRP	101036	2016.07.05	2017.07.04	<input checked="" type="checkbox"/>
LISN	SCHWARZBECK	NSLK 8127	8127-687	2016.07.05	2017.07.04	<input checked="" type="checkbox"/>
LISN	SCHWARZBECK	NNLK 8129	8129-462	2016.09.14	2017.09.13	<input type="checkbox"/>
AMN	SCHWARZBECK	NNBM8124	8124-509	2016.07.05	2017.07.04	<input type="checkbox"/>
AMN	SCHWARZBECK	NNBM8124	8124-510	2016.07.05	2017.07.04	<input type="checkbox"/>
ISN	TESEQ	ISN T800	34449	2016.07.05	2017.07.04	<input type="checkbox"/>
Shielded Enclosure	ChangNing	CN-130701	130703	N/A	N/A	<input checked="" type="checkbox"/>

#### 4.3 Test Enclosure list

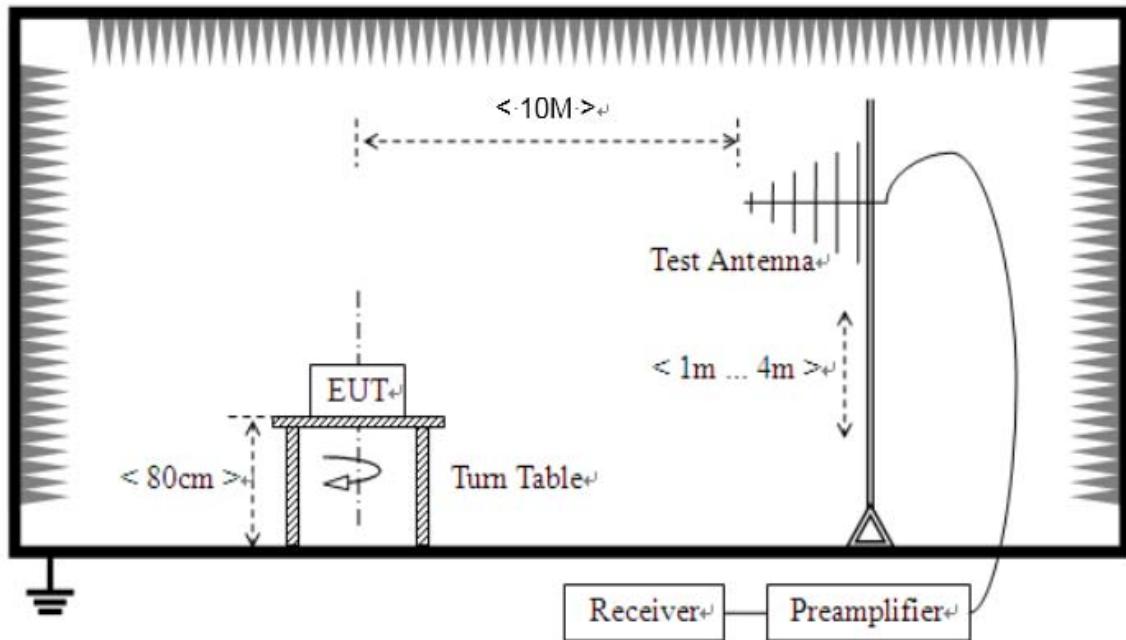
Description	Manufacturer	Model	Serial No.	Length	Description	Use
PC	Dell	015K3N	N/A	N/A	Special Handled	<input checked="" type="checkbox"/>
Laptop	Apple	A1465	N/A	N/A	N/A	<input type="checkbox"/>
Printer	HP	DESKJET 1000	N/A	N/A	N/A	<input checked="" type="checkbox"/>
Keyboard	Dell	N/A	N/A	N/A	N/A	<input checked="" type="checkbox"/>
Mouse	Dell	N/A	N/A	N/A	N/A	<input checked="" type="checkbox"/>
USB disk	Kingston	N/A	N/A	N/A	N/A	<input type="checkbox"/>
TF Card	Kingston	N/A	N/A	N/A	N/A	<input checked="" type="checkbox"/>
VGA Cable	N/A	N/A	N/A	1.5 m	Shielded with core	<input type="checkbox"/>
HDMI Cable	N/A	N/A	N/A	1.5 m	Shielded with core	<input type="checkbox"/>
DVI Cable	N/A	N/A	N/A	1.5 m	Shielded with core	<input type="checkbox"/>
Coaxial video cable	N/A	N/A	N/A	2.0 m	Shielded with core	<input type="checkbox"/>
iPhone	Apple	A1586	N/A	N/A	N/A	<input type="checkbox"/>
Phone	MI	M4	N/A	N/A	N/A	<input type="checkbox"/>
Bluetooth Earphone	SAMSUNG	Gear Circle	N/A	N/A	N/A	<input checked="" type="checkbox"/>
GPS/GLONAS S Vector signal generator	R&S	N5172B EXG	N/A	N/A	N/A	<input checked="" type="checkbox"/>
WIFI Router	TP-LINK	TL-WDR7500	N/A	N/A	N/A	<input checked="" type="checkbox"/>
Earphone	N/A	OPPO	N/A	1.1 m	N/A	<input type="checkbox"/>
Car Battery	Camel	55530	N/A	N/A	12 V/55 Ah	<input type="checkbox"/>
Artificial load	N/A	N/A	N/A	N/A	2.5 Ω/100 W	<input type="checkbox"/>
Artificial load	N/A	N/A	N/A	N/A	5 Ω/100 W	<input type="checkbox"/>
Electronic Load	ITECH	IT8511	N/A	N/A	N/A	<input type="checkbox"/>
USB Cable	N/A	N/A	N/A	1.5 m	Shielded with core	<input type="checkbox"/>
DC Power Supply	ITECH	IT6863A	60001401068 7210006	N/A	N/A	<input type="checkbox"/>
LCD Monitor	SAMSUNG	UA32C4000P	N/A	N/A	N/A	<input type="checkbox"/>
LCD Monitor	Dell	U241HB	N/A	N/A	N/A	<input type="checkbox"/>
RJ45 Cable	N/A	N/A	N/A	1.5 m	Shielded with core	<input type="checkbox"/>

## 4.4 Test Configurations

Test Configurations (TC) No.	Description
Traffic Test Mode	
TC01	<u>The GSM 850 MHz Test Mode</u> GSM 850 Link + Adapter + USB Cable + Battery + Earphone + BT Link + WIFI Link + GLONASS RX
TC02	<u>The EDGE 850 MHz Test Mode</u> EDGE 850 Link + Adapter + USB Cable + Battery + Earphone + BT Link + WIFI Link + GPS RX
TC03	<u>The GSM 1900 Test Mode</u> GSM 1900 Link + Adapter + USB Cable + Battery + Earphone + BT Link + WIFI Link + GPS RX
TC04	<u>The EDGE 1900 MHz Test Mode</u> EDGE 1900 Link + Adapter + USB Cable + Battery + Earphone + BT Link + WIFI Link + GLONASS RX
TC05	<u>The WCDMA Band 2 Test Mode</u> WCDMA Band 2 Link + Adapter + USB Cable + Battery + Earphone + BT Link + WIFI Link + GLONASS RX
TC06	<u>The WCDMA Band 4 test mode</u> WCDMA Band 4 Link + Adapter + USB Cable + Battery + Earphone + BT Link + WIFI Link + GPS RX
TC07	<u>The WCDMA Band 5 test mode</u> WCDMA Band 5 Link + Adapter + USB Cable + Battery + Earphone + BT Link + WIFI Link + GPS RX
TC08	<u>The FDD LTE Band 2 Test Mode</u> LTE Band 2 Link + Adapter + USB Cable + Battery + Earphone + BT Link + WIFI Link + GLONASS RX
TC09	<u>The FDD LTE Band 4 Test Mode</u> LTE Band 4 Link + Adapter + USB Cable + Battery + Earphone + BT Link + WIFI Link + GPS RX
TC10	<u>The FDD LTE Band 7 Test Mode</u> LTE Band 7 Link + Adapter + USB Cable + Battery + Earphone + BT Link + WIFI Link + GLONASS RX
TC11	<u>The Idle Test Mode</u> GSM 850(Idle) + Battery + Adapter + USB Cable + Earphone + FM RX
Amusement Test Mode	
TC12	<u>The Download Test Mode</u> EUT + USB Cable + Battery + Earphone + TF Card + PC + Printer + Keyboard + Mouse
TC13	<u>The Video Record Test Mode</u> EUT + Adapter + USB Cable + Battery + Earphone + TF Card
TC14	<u>The Video Play Test Mode</u> EUT + Adapter + USB Cable + Battery + Earphone + TF Card

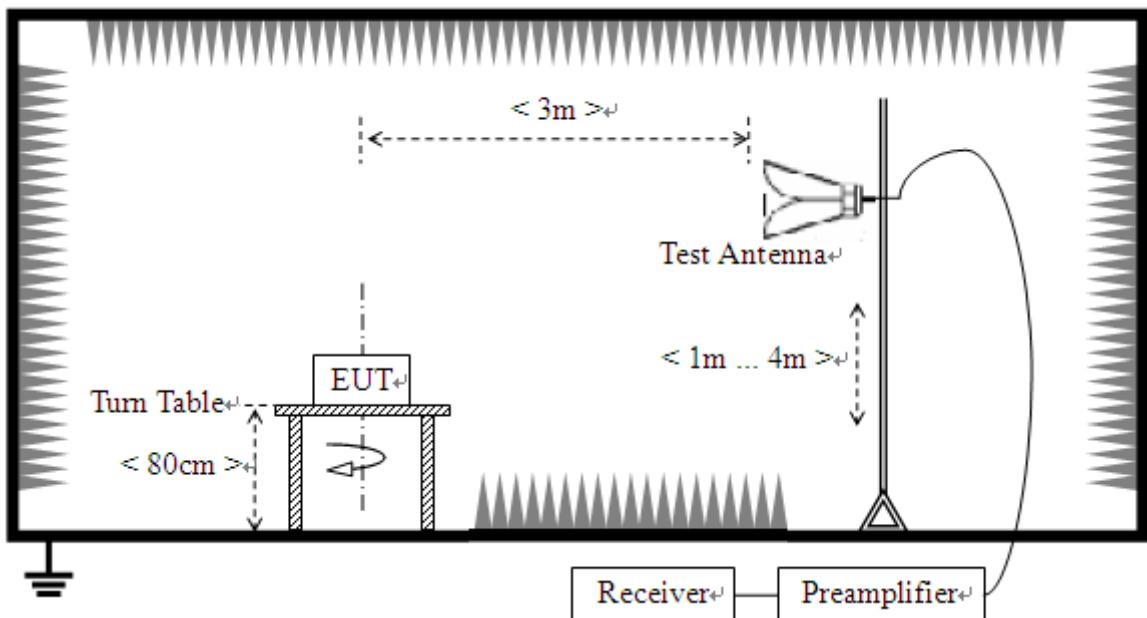
## 4.5 Test Setups

### Test Setup 1

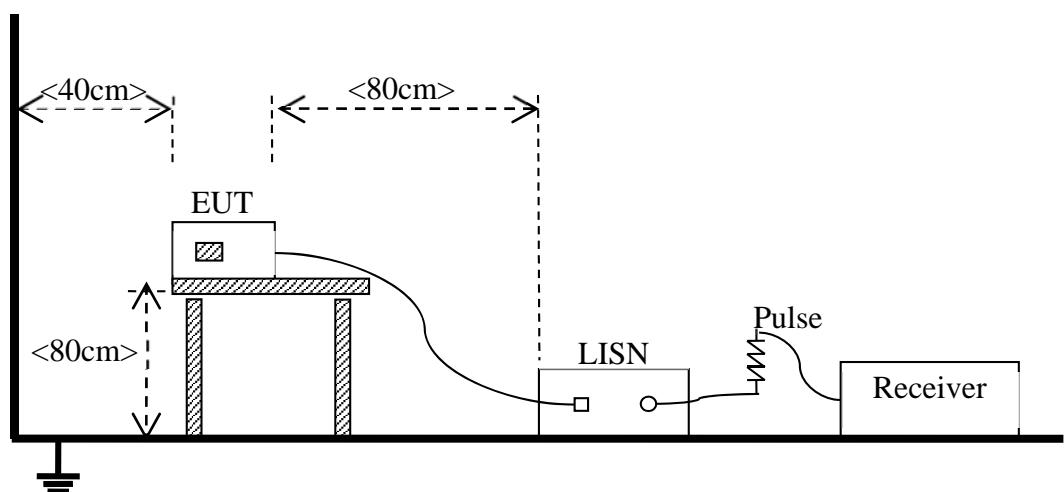


(For Radiated Emission Test (30 MHz-1 GHz))

### Test Setup 2



(For Radiated Emission Test (above 1 GHz))

Test Setup 3

(For Conducted Emission, AC Ports Test)

## 4.6 Test Conditions

Test Case	Test Conditions	
Radiated Emission	Test Env.	NTNV
	Test Setup	Test Setup 1&2
	Test Configuration	TC01~TC14 <small>Note</small>
Conducted Emission, AC Ports	Test Env.	NTNV
	Test Setup	Test Setup 3
	Test Configuration	TC01~TC14 <small>Note</small>
Note: Based on client request, all normal using modes of the normal function were tested but only the worst test data of the worst mode is reported by this report. The GSM 850 MHz test mode is the worst mode in this report.		

## 5 TEST ITEMS

### 5.1 Emission Tests

#### 5.1.1 Radiated Emission

##### 5.1.1.1 Limit

Frequency range (MHz)	Class B (at 3 m)		Class A (at 10 m)	
	Field Strength ( $\mu$ V/m)	Field Strength (dB $\mu$ V/m)	Field Strength ( $\mu$ V/m)	Field Strength (dB $\mu$ V/m)
30 - 88	100	40	90	39
88 - 216	150	43.5	150	43.5
216 - 960	200	46	210	46.4
Above 960	500	54	300	49.5

NOTE:

- 1) Field Strength (dB $\mu$ V/m) = 20\*log [Field Strength ( $\mu$ V/m)].
- 2) In the emission tables above, the tighter limit applies at the band edges.

##### 5.1.1.2 Test Setup

Refer to 4.5 section (test setup 1 to test setup 2) for radiated emission test, the photo of test setup please refer to ANNEX B.

##### 5.1.1.3 Test Procedure

All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

An initial pre-scan was performed in the chamber using the EMI Receiver in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by Bi-Log antenna with 2 orthogonal polarities.

##### 5.1.1.4 Test Result

Please refer to ANNEX A.1.

## 5.1.2 Conducted Emission

### 5.1.2.1 Test Limit

Frequency range (MHz)	Class A	
	Quasi-peak (dB $\mu$ V)	Average (dB $\mu$ V)
0.15 - 0.50	79	66
0.50 - 30	73	60

Frequency range (MHz)	Class B	
	Quasi-peak (dB $\mu$ V)	Average (dB $\mu$ V)
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

#### NOTE:

- 1) The lower limit shall apply at the band edges.
- 2) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50 MHz.

### 5.1.2.2 Test Setup

Refer to 4.5 section test (test setup 3) for conducted emission, the photo of test setup please refer to ANNEX B.

### 5.1.2.3 Test Procedure

The EUT is connected to the power mains through a LISN which provides 50  $\Omega$ /50  $\mu$ H of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

### 5.1.2.4 Test Result

Please refer to ANNEX A.2.

## ANNEX A TEST RESULTS

### A.1 Radiated Emission

Note 1: The symbol of “--” in the table which means not application.

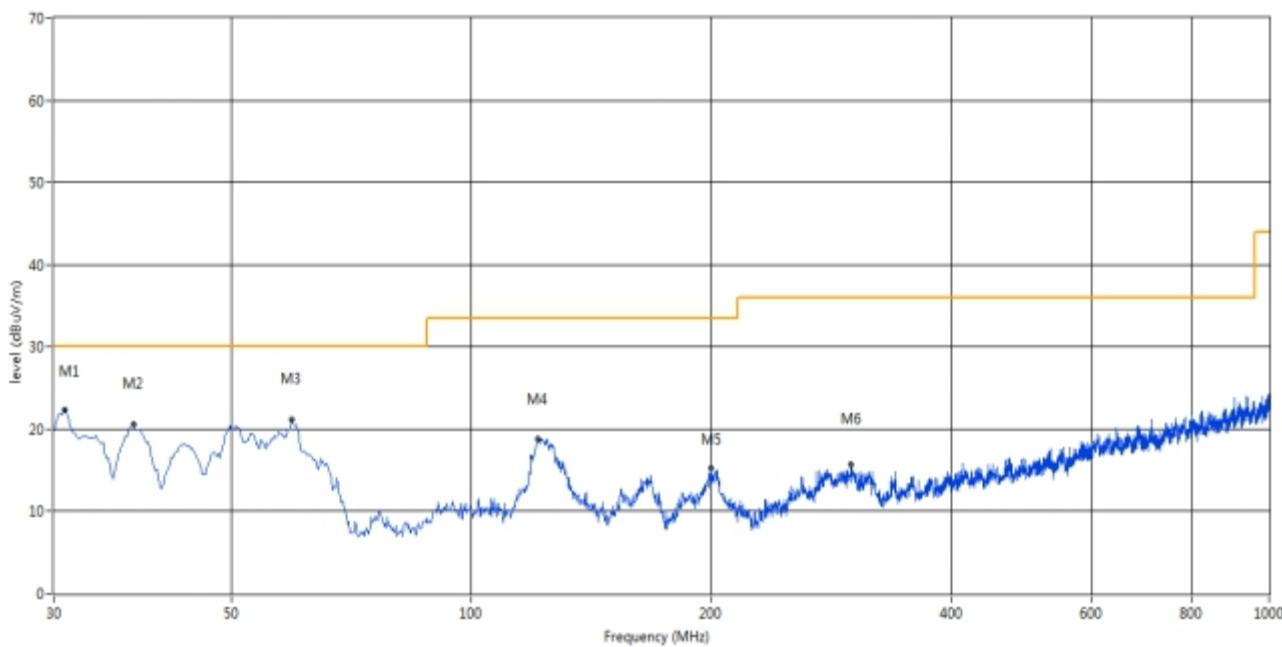
Note 2: For the test data above 1 GHz, according the ANSI C63.4-2014, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Note 3: This frequency which near 850 MHz with circle should be ignored because they are MS and SS carrier frequency, the marked spikes near 2400 MHz with circle should be ignored because they are Bluetooth or WIFI carrier frequency.

#### Test Data and Plots

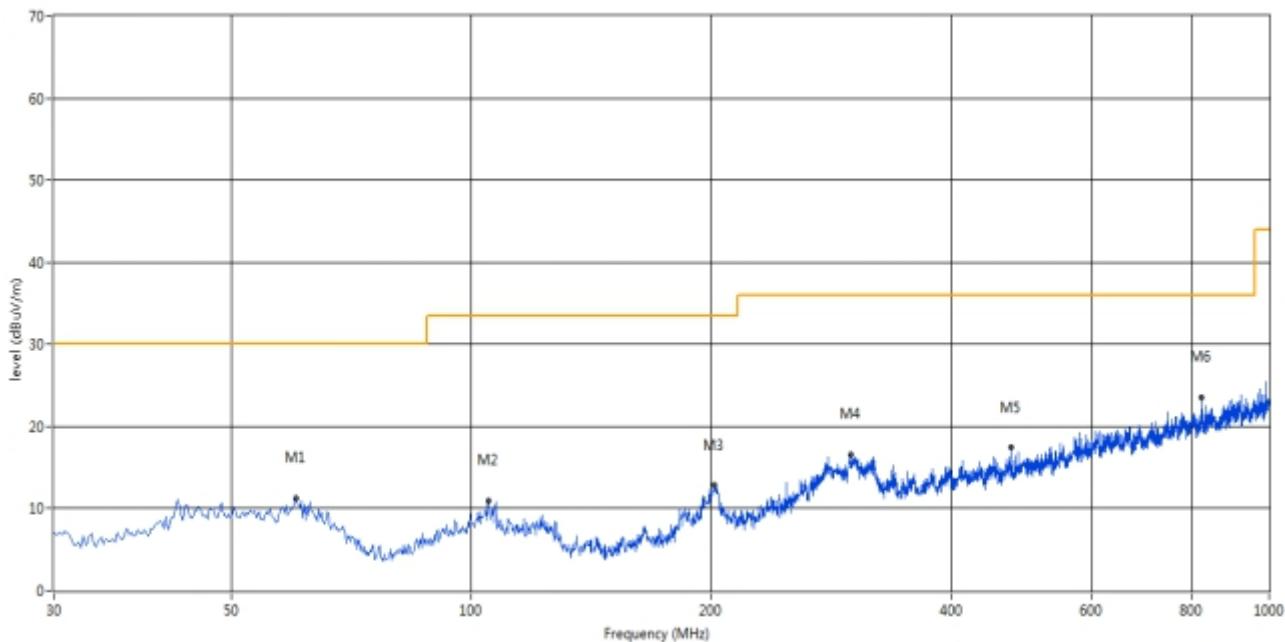
##### The GSM 850 MHz Test Mode

###### A.1.1 Test Antenna Vertical, 30 MHz – 1 GHz



No.	Frequency (MHz)	Results (dB <sub>uV/m</sub> )	Factor (dB)	Limit (dB <sub>uV/m</sub> )	Margin (dB)	Detector	Table (o)	Height (cm)	ANT	Verdict
1	30.970	22.35	-16.82	30.0	7.65	Peak	68.00	100	Vertical	Pass
2	37.758	20.63	-15.03	30.0	9.37	Peak	212.00	100	Vertical	Pass
3	59.578	21.15	-14.95	30.0	8.85	Peak	51.00	100	Vertical	Pass
4	121.400	18.74	-17.34	33.5	14.76	Peak	0.00	200	Vertical	Pass
5	199.708	15.29	-15.05	33.5	18.21	Peak	345.00	100	Vertical	Pass
6	299.350	15.63	-12.31	36.0	20.37	Peak	253.00	100	Vertical	Pass

## A.1.2 Test Antenna Horizontal, 30 MHz – 1 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (o)	Height (cm)	ANT	Verdict
1	60.305	11.27	-15.06	30.0	18.73	Peak	347.00	400	Horizontal	Pass
2	105.156	10.95	-15.02	33.5	22.55	Peak	138.00	200	Horizontal	Pass
3	201.647	12.81	-15.03	33.5	20.69	Peak	63.00	400	Horizontal	Pass
4	299.108	16.54	-12.32	36.0	19.46	Peak	73.00	400	Horizontal	Pass
5	474.876	17.41	-8.31	36.0	18.59	Peak	0.00	200	Horizontal	Pass
6	823.504	23.54	-2.05	36.0	12.46	Peak	304.00	300	Horizontal	Pass

### Test Data and Plots (Above 1 GHz)

#### A.1.3 Test Antenna Vertical, 1 GHz – 6 GHz

Note: Test Data and Plots (Above 1 GHz) result reference from original test report: BL-SZ1720179-401 (issued by Shenzhen BALUN Technology Co., Ltd. On May 15, 2017) A.1.3 Test Antenna Vertical, 1 GHz - 6 GHz

#### A.1.4 Test Antenna Horizontal, 1 GHz – 6 GHz

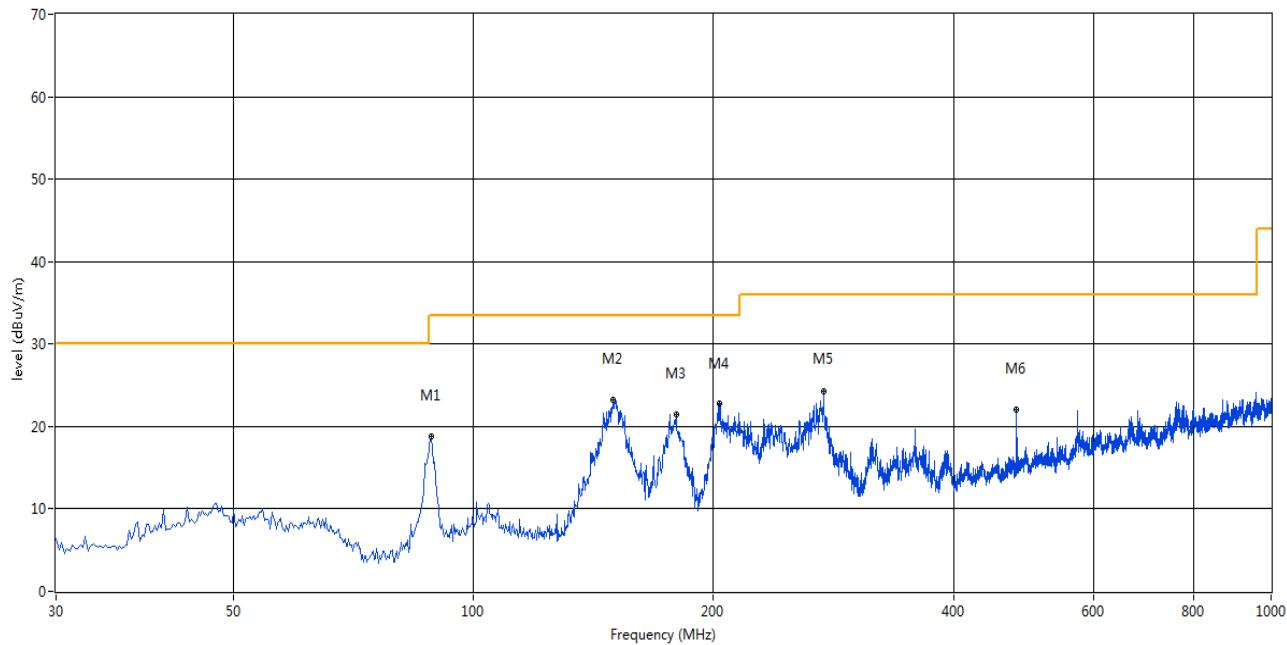
Note: Test Data and Plots (Above 1 GHz) result reference from original test report: BL-SZ1720179-401 (issued by Shenzhen BALUN Technology Co., Ltd. On May 15, 2017) A.1.4 Test Antenna Horizontal, 1 GHz - 6 GHz

## Test Data and Plots

### The USB Test Mode

#### A.1.5 Test Antenna Vertical, 30 MHz – 1 GHz

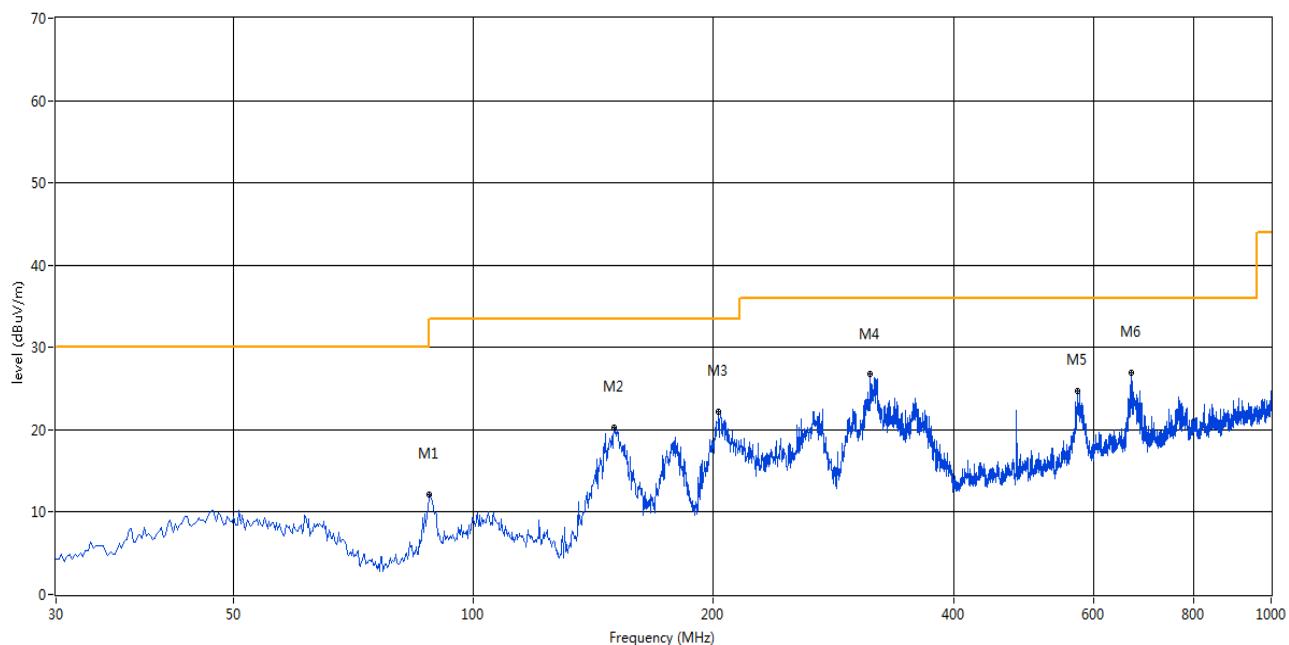
RE Test Case\_FCC Certification\_FCC 15B ClassB 30MHz-1GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (o)	Height (cm)	ANT	Verdict
1	88.670	18.77	-17.45	33.5	14.73	Peak	0.00	200	Vertical	Pass
2	149.523	23.19	-18.71	33.5	10.31	Peak	3.00	100	Vertical	Pass
3	179.585	21.51	-16.96	33.5	11.99	Peak	99.00	100	Vertical	Pass
4	203.829	22.73	-14.92	33.5	10.77	Peak	0.00	200	Vertical	Pass
5	274.864	24.29	-13.02	36.0	11.71	Peak	229.00	100	Vertical	Pass
6	479.968	22.07	-8.21	36.0	13.93	Peak	273.00	100	Vertical	Pass

## A.1.6 Test Antenna Horizontal, 30 MHz – 1 GHz

RE Test Case\_FCC Certification\_FCC 15B ClassB 30MHz-1GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (o)	Height (cm)	ANT	Verdict
1	88.185	12.18	-17.58	33.5	21.32	Peak	268.00	400	Horizontal	Pass
2	150.250	20.33	-18.68	33.5	13.17	Peak	251.00	400	Horizontal	Pass
3	202.859	22.25	-14.98	33.5	11.25	Peak	32.00	400	Horizontal	Pass
4	314.139	26.73	-11.95	36.0	9.27	Peak	260.00	300	Horizontal	Pass
5	572.579	24.77	-6.11	36.0	11.23	Peak	42.00	200	Horizontal	Pass
6	668.100	26.92	-4.49	36.0	9.08	Peak	178.00	100	Horizontal	Pass

#### A.1.7 Test Antenna Vertical, 1 GHz – 6 GHz

Note: Test Data and Plots (Above 1 GHz) result reference from original test report: BL-SZ1720179-401 (issued by Shenzhen BALUN Technology Co., Ltd. On May 15, 2017) A.1.7 Test Antenna Vertical, 1 GHz - 6 GHz

#### A.1.8 Test Antenna Horizontal, 1 GHz – 6 GHz

Note: Test Data and Plots (Above 1 GHz) result reference from original test report: BL-SZ1720179-401 (issued by Shenzhen BALUN Technology Co., Ltd. On May 15, 2017) A.1.8 Test Antenna Horizontal, 1 GHz - 6 GHz

## A.2 Conducted Emission

Note: Conducted Emission Test Data and Plots result reference from original test report: BL-SZ1720179-401 (issued by Shenzhen BALUN Technology Co., Ltd. On May 15, 2017) A.2 Conducted Emission.

## **ANNEX B TEST SETUP PHOTOS**

Please refer the document "BL-SZ1720179-AE.PDF".

## **ANNEX C EUT EXTERNAL PHOTOS**

Please refer the document "BL-SZ1720179-AW.PDF".

## **ANNEX D EUT INTERNAL PHOTOS**

Please refer the document "BL-SZ1720179-AI.PDF".

--END OF REPORT--